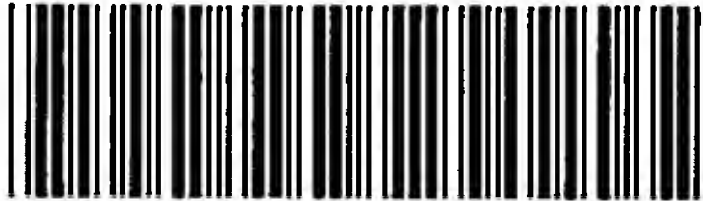


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,895	TSIRLINE ET AL.	
	Examiner	Art Unit	
	Uyen-Chau N. Le	2876	

SEARCHED			
Class	Subclass	Date	Examiner
235	375,432, 439,449, 450,451, 493	11/12/2005	UCL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
235/375,432,439,449,450,451,493 (text search only -- see search history printout)	11/12/2005	UCL
400/76,70,61,88,719 (text search only -- see search history printout)	11/12/2005	UCL
340/572.1,572.2,572.7,572.8 (text search only -- see search history printout)	11/12/2005	UCL
343/700ms (text search only -- see search history printout)	11/12/2005	UCL
101/35 (text search only -- see search history printout)	11/12/2005	UCL
EAST (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	11/12/2005	UCL
REVIEW APP. 10/249,039 AND 10/863,055	11/12/2005	UCL